

RoHS Compliant Product  
A suffix of "-C" specifies halogen & lead-free

## DESCRIPTION

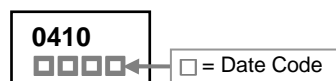
The SGM0410 is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The SGM0410 meet the RoHS and Green Product requirement with full function reliability approved.

## FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Green Device Available

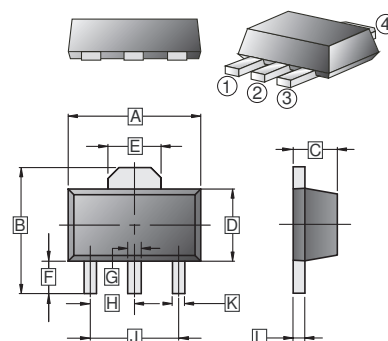
## MARKING



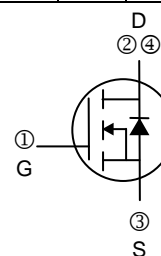
## PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-89	1K	7 inch

## SOT-89



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.40	4.60	G	0.40	0.58
B	3.94	4.25	H	1.50 TYP	
C	1.40	1.60	J	3.00 TYP	
D	2.25	2.60	K	0.32	0.52
E	1.55 TYP.		L	0.35	0.44
F	0.89	1.20			



## ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup> @ $V_{GS}=10\text{V}$	$I_D$	$T_A=25^\circ\text{C}$	3.5
		$T_A=70^\circ\text{C}$	2.8
Pulsed Drain Current <sup>3</sup>	$I_{DM}$	10	A
Power Dissipation	$P_D$	1.5	W
Operating Junction and Storage Temperature	$T_J, T_{STG}$	-65~150	$^\circ\text{C}$
<b>Thermal Resistance Rating</b>			
Maximum Thermal Resistance from Junction to Ambient <sup>1</sup>	$R_{\theta JA}$	$t \leq 10\text{s}, 50$	$^\circ\text{C} / \text{W}$
		Steady State, 85	
Maximum Thermal Resistance from Junction to Ambient <sup>2</sup>	$R_{\theta JA}$	135	$^\circ\text{C} / \text{W}$
Maximum Thermal Resistance from Junction to Case <sup>1</sup>	$R_{\theta JC}$	36	$^\circ\text{C} / \text{W}$

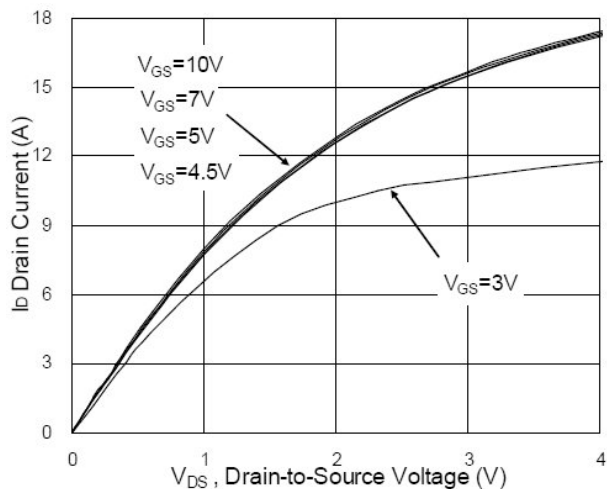
**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Drain-Source Breakdown Voltage	$BV_{DSS}$	100	-	-	V	$V_{GS}=0, I_D=250\mu\text{A}$
Gate Threshold Voltage	$V_{GS(th)}$	1	-	2.5	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
Forward Transfer conductance	$g_{fs}$	-	4	-	S	$V_{DS}=5\text{V}, I_D=2\text{A}$
Gate-Source Leakage Current	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS}=\pm 20\text{V}$
Drain-Source Leakage Current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$V_{DS}=80\text{V}, V_{GS}=0, T_J=25^\circ\text{C}$
		-	-	10		$V_{DS}=80\text{V}, V_{GS}=0, T_J=55^\circ\text{C}$
Static Drain-Source On-Resistance <sup>4</sup>	$R_{DS(ON)}$	-	-	170	m $\Omega$	$V_{GS}=10\text{V}, I_D=2.6\text{A}$
		-	-	200		$V_{GS}=5\text{V}, I_D=1.7\text{A}$
Total Gate Charge	$Q_g$	-	20	-	nC	$I_D=6\text{A}$ $V_{DS}=50\text{V}$ $V_{GS}=10\text{V}$
Gate-Source Charge	$Q_{gs}$	-	4	-		
Gate-Drain ("Miller") Charge	$Q_{gd}$	-	5	-		
Turn-On Delay Time	$T_{d(on)}$	-	17.3	-	nS	$V_{DD}=50\text{V}$ $I_D=1\text{A}$ $V_{GS}=10\text{V}$ $R_G=3.3\Omega$ $R_D=50\Omega$
Rise Time	$T_r$	-	2.8	-		
Turn-Off Delay Time	$T_{d(off)}$	-	50	-		
Fall Time	$T_f$	-	2.8	-		
Input Capacitance	$C_{iss}$	-	1077	-	pF	$V_{GS}=0$ $V_{DS}=15\text{V}$ $f=1\text{MHz}$
Output Capacitance	$C_{oss}$	-	46	-		
Reverse Transfer Capacitance	$C_{rss}$	-	32	-		
<b>Source-Drain Diode</b>						
Continuous Source Current <sup>1</sup>	$I_S$	-	-	3.5	A	
Pulsed Source Current <sup>3</sup>	$I_{SM}$	-	-	10	A	
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	-	-	1.2	V	$I_S=3.5\text{A}, V_{GS}=0\text{V}$
Reverse Recovery Time	$t_{rr}$	-	26	-	nS	$I_F=6\text{A}, dl/dt=100\text{A}/\mu\text{s},$ $T_J=25^\circ\text{C}$
Reverse Recovery Charge	$Q_{rr}$	-	15	-	nC	

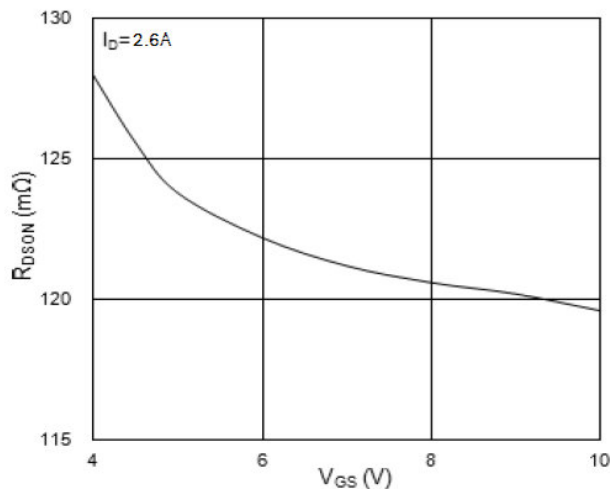
Notes:

1. Surface mounted on a 1 inch<sup>2</sup> FR4 board with 20Z copper
2. When mounted on Min. copper pad.
3. Pulse width limited by Max. junction temperature.
4. Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

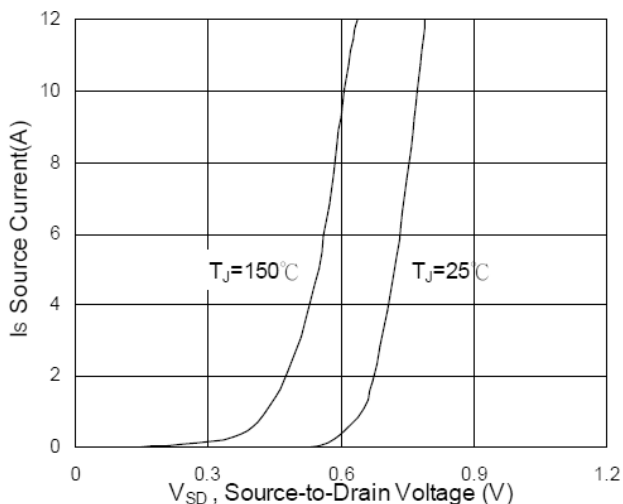
**CHARACTERISTIC CURVES**



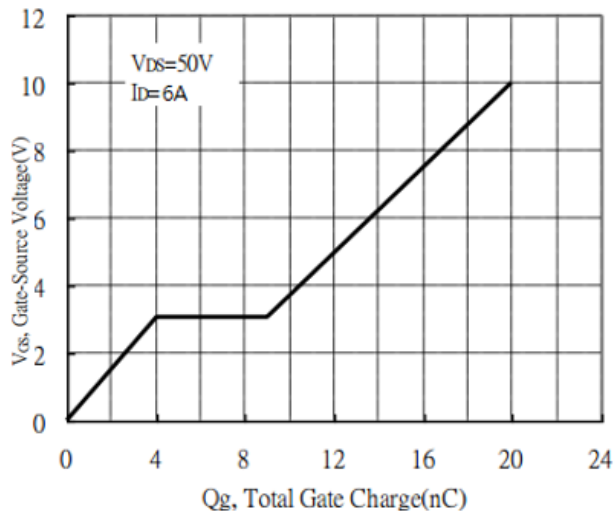
**Fig.1 Typical Output Characteristics**



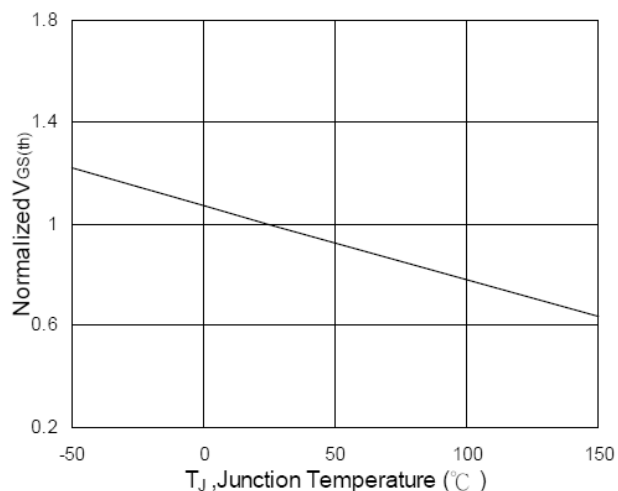
**Fig.2 On-Resistance vs. Gate-Source**



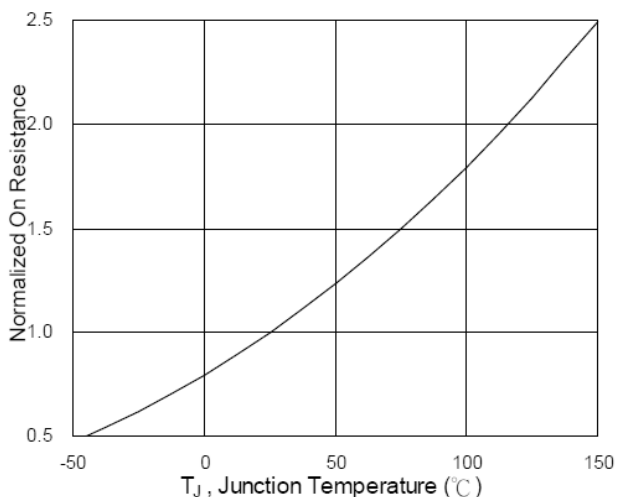
**Fig.3 Forward Characteristics Of Reverse**



**Fig.4 Gate-Charge Characteristics**



**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**



**Fig.6 Normalized  $R_{DS(ON)}$  vs.  $T_J$**

**CHARACTERISTIC CURVES**

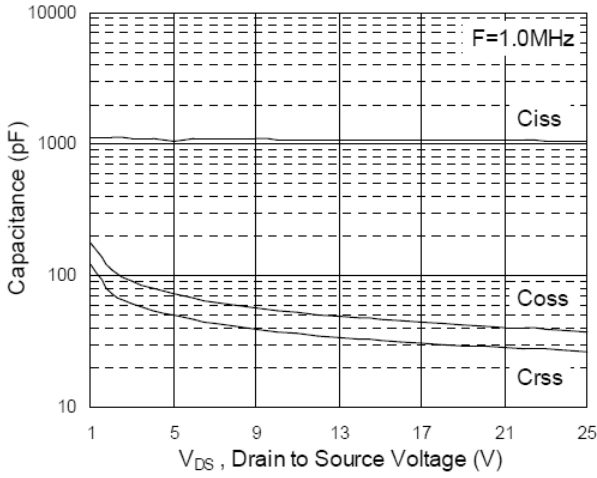


Fig.7 Capacitance

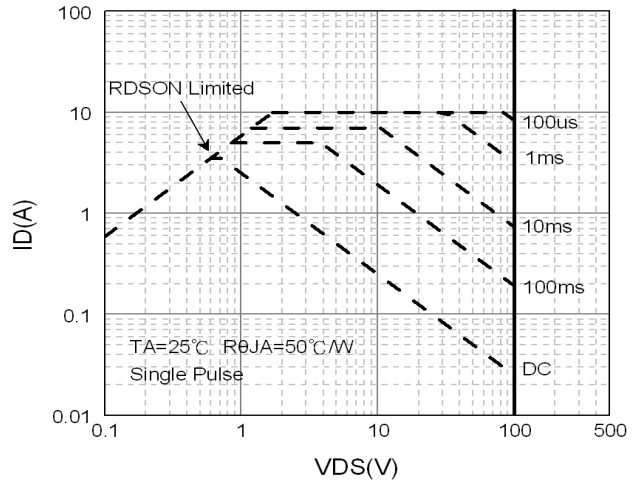


Fig.8 Safe Operating Area

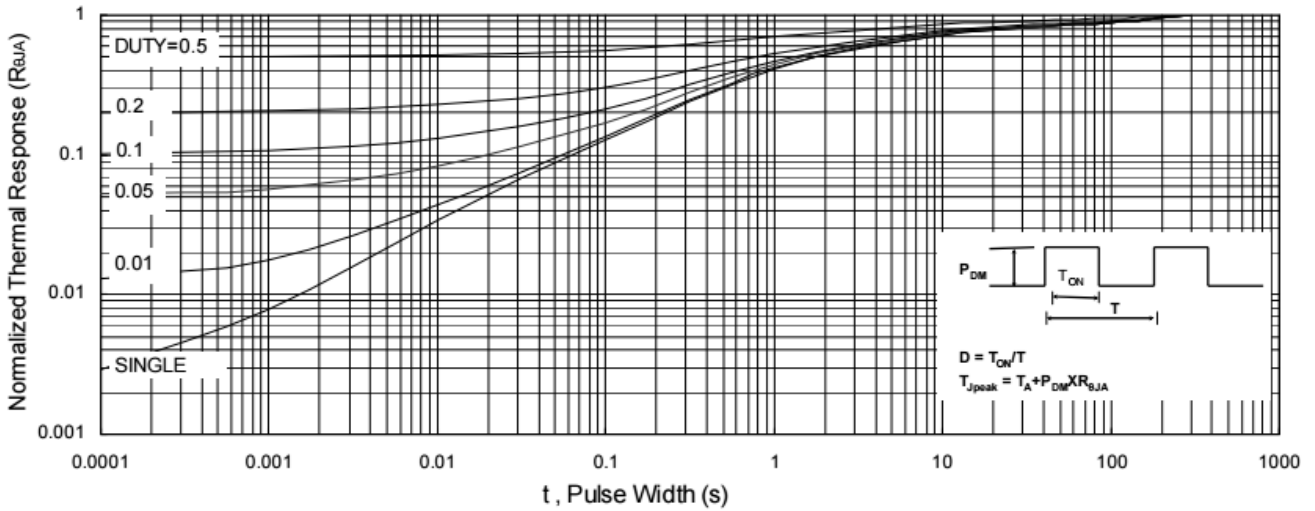


Fig.9 Normalized Maximum Transient Thermal Impedance

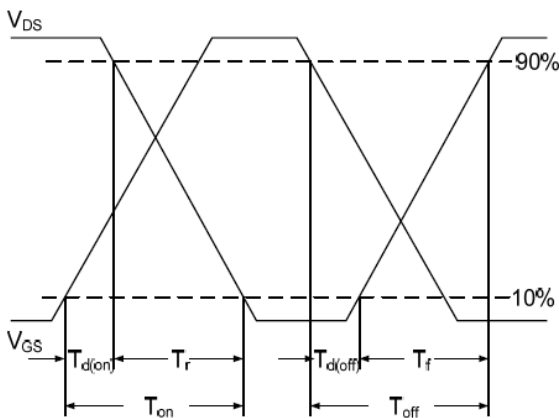


Fig.10 Switching Time Waveform

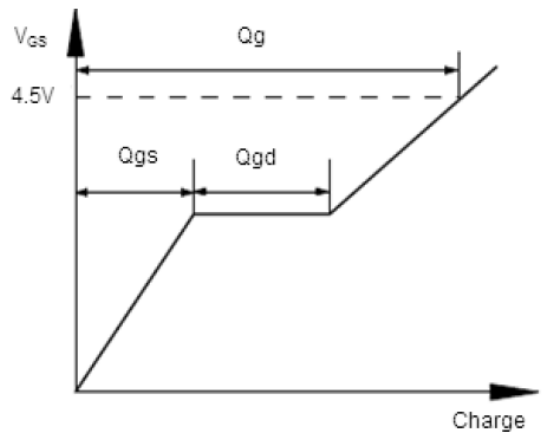


Fig.11 Gate Charge Waveform